Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10710600	FUJISAKI, IWAO
Examiner	Art Unit

DAVID Q NGUYEN

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SEARCHED

Class	Subclass	Date	Examiner
455	556.1	04/21/09	DN
370	338	04/21/09	DN
455	456.1	08/12/09	DN
705	26	08/12/09	DN
340	426.1	08/12/09	DN
update		10/14/2009	DN
search			
update		04/08/10	DN
search			
455	558	04/08/10	DN
455	567	04/08/10	DN
455	410	04/08/10	DN

SEARCH NOTES		
Search Notes	Date	Examiner
Text search	04/21/09	DN
Text search	08/12/09	DN
Text search	10/24/2009	DN
Text search	04/08/10	DN

	INTERFERENCE SEARC	СН	
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